Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/091,047	SHIEH, HUGH H.
Examiner	Art Unit
Jason K. Gee	2134

	SEARCHED				
Class	Subclass	Date	Examiner		
713	185	8/3/2007	JKG		
			,		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
PALM - Inventor Name Search	8/3/2007	JKG
EAST - US_PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	8/3/2007	JKG